SERI/TP-212-2329 UC Category: 63 DE84004514

# CulnSe<sub>2</sub>-Based Photoelectrochemical Cells: Their Use in Characterization of Thin CulnSe<sub>2</sub> Films, and as Photovoltaic Cells Per Se

D. Cahen Y. W. Chen P. J. Ireland R. Noufi J. A. Turner Solar Energy Research Institute C. Rincon

Universidad de Los Andes K. J. Bachmann

North Carolina State University

# May 1984

Presented at the 17th IEEE PV Specialists Conference Orlando, Florida; 1–5 May 1984

Prepared under Task No. 3436.23 FTP No. 462

# **Solar Energy Research Institute**

A Division of Midwest Research Institute

1617 Cole Boulevard Golden, Colorado 80401

Prepared for the U.S. Department of Energy Contract No. DE-AC02-83CH10093

Printed in the United States of America Available from: National Technical Information Service U.S. Department of Commerce 5285 Port Royal Road Springfield, VA 22161 Price: Microfiche A01 Printed Copy A02

# NOTICE

This report was prepared as an account of work sponsored by the United States Government. Neither the United States nor the United States Department of Energy, nor any of their employees, nor any of their contractors, subcontractors, or their employees, makes any warranty, express or implied, or assumes any legal liability or responsibility for the accuracy, completeness or usefulness of any information, apparatus, product or process disclosed, or represents that its use would not infringe privately owned rights.

# CuinSe<sub>2</sub>-BASED PHOTOELECTROCHEMICAL CELLS: THEIR USE IN CHARACTERIZATION OF THIN CuinSe<sub>2</sub> Films, AND AS PHOTOVOLTAIC CELLS PER SE

David Cahen,\* Y. W. Chen, P. J. Ireland, R. Noufi, J. A. Turner Solar Energy Research Institute Golden, CO, U.S.A.

C. Rincon Departamento de Física Universidad de Los Andes Mérida, Venezuela. K. J. Bachmann Department of Chemistry North Carolina State University Raleigh, NC, U.S.A.

## ABSTRACT

Photoelectrochemistry has been employed to characterize the  $p-CuInSe_2$  component of the CdS/CuInSe\_ photovoltaic cell. Using the junction between CuInSe2 on-metal and a nonaqueous electrolyte containing a redox couple not specifically adsorbed onto the semiconductor, we can test the films for photovoltaic activity and obtain effec-tive electronic properties of them, before CdS deposition, in a nondestructive manner. Electrochemical decomposition of CuInSe<sub>2</sub> was investigated in acetonitrile solutions to determine the mechanism of decomposition (n & p) in the dark and under illumination. Electrochemical, solution chemical and surface analyses confirmed at the light-assisted decomposition of CuInSe<sub>2</sub> resulted in metal ions and elemental chalcogen. On the basis of the results from the electrochemical decomposition, and studies on the solid state chemistry of the  $(Cu_2Se)_x(In_2Se_3)_{1\rightarrow x}$  system and surface analyses, the CuInSe<sub>2</sub>/polyiodide interface was stabilized and up to 11.7% conversion efficiencies were obtained.

#### INTRODUCTION

Single crystal and thin film CuInSe<sub>2</sub> - based solar cells have shown appreciable conversion efficiencies (>10%) and impressive output stabilities (1,2). The Cd(Zn)S/CuInSe<sub>2</sub> thin film solar cell is a multilayer device. Up to 6 layers are used in state-of-the-art thin film devices (1). The reproducible fabrication of the complete cell depends on the many factors that control the preparation of each of these layers. Up to now the photovoltaic quality of the layers could be assessed only by measuring the characteristics of the complete devices. Therefore, we developed a photoelectro-chemical (PEC) system which allows tests of the photovoltaic activities of the individual CuInSe, on Mo films and layer patterns in a non-destructive way. Different redox electrolytes might need to be chosen due to different energetics and chemical behavior of the semiconductor.

Respectable performances were obtained also for  $n-CuInSe_2/polysulfide$  electrochemical photo-

voltaic cells (3). n-CuInS<sub>2</sub> and CuInSe<sub>2</sub>, I-III-VI<sub>2</sub> materials with the chalcopyrite structure (4), have shown excellent output stabilities at reasonable conversion efficiencies, when used as single crystal photoanodes in aqueous polysulfide (5). It is apparent that kinetic factors limit the performance of this system. Therefore, we searched for a redox couple with fast kinetics as compared to the sulfide/polysulfide couple. The iodide/polyiodide is such a couple that has been used with elemental or binary semiconductor photoanodes (6). However, redox couples with electrochemical potentials positive of the sulfide/polysulfide couple generally do not protect low bandgap photoanodes from photodecomposition (7). Here we report on the stabilization of efficient n-CuInSe<sub>2</sub> photoanodes in aqueous polyiodide solution (8).

#### EXPERIMENTAL

p-CuInSe<sub>2</sub> thin films were prepared by multisource vacuum evaporation (1) on alumina substrates, that were metallized with a thin film of Mo. They were kindly supplied by R.A. Mickelsen (Boeing Engineering and Construction Co.) and by R. Axton (SERI). The films were about 3.3 µm thick and were deposited in two layers; the first (2.5  $\mu$ m) at a substrate temperature of 350°C, and the second (0.8 µm) at 450°C. The p-CuInSe, crystals were grown by C. Rincon, and ohmic contact was made by evaporating Au onto one surface and using silver epoxy to connect the crystal to a copper wire. Except for one working face, the others were covered by epoxy (Devcon Corp., Danvers, Mass.) or sometimes by tar. Because the p-CuInSe<sub>2</sub> films were deposited on Mo, direct pressure contact or contact using Ag epoxy was made directly to the Mo. n-Type CuInSe<sub>2</sub> crystals, obtained from C. Rincon (9) and K. Bachmann (10), had  $10^{16} - 10^{17}$  cm<sup>-3</sup> majority carrier density, 600-850 cm<sup>2</sup>V<sup>-1</sup>sec<sup>-1</sup> Hall mobilities and 1 - 10  $\Omega$ -cm resistivities. Most of the n-crystals were cut along the (112) plane. p-Type CuInSe<sub>2</sub> crystals were obtained from multicrystalline chunks, prepared by F.A. Thiel (A.T.&T. Bell Labs). They were cut along random directions, to isolate simple crystalline zones. They had an acceptor density of ca.  $10^{18}$  cm<sup>-3</sup> and a resistivity of ca.  $10^{-2}\Omega$ -cm. The stoichiometry of all crystals and thin films was checked by electron beam-induced wavelengthdispertive X-ray fluorescence, after calibrating this method by wet chemical analyses on some

<sup>\*</sup>On leave from Weizmann Institute of Science, Rehovolt, Israel.

samples. All crystals were polished and ohmic contact was made with to one side with In-Ga alloy (n-type), or by evaporating Au (p-type). Except for one face, the crystals were covered by "Torr-Seal" epoxy.

A PAR Model 173 potentiostat with Model 175 Universal Programmer was used for voltammetric measurements in the dark and under illumination. The light source was a 150 W tungsten-halogen lamp. An H-cell with optical window was employed for the photoelectrochemical measurements. A helium-neon laser with scanning set-up (11) was used to test the spatial homogeneity of p-CuInSe<sub>2</sub> films. The experimental set-up for Mott-Schottky measurements was as described previously (12).

# RESULTS AND DISCUSSION

### Evaluation of Photovoltaic Activity

The primary purpose was to develop a diagnostic method for non-invasive evaluation of the photovoltaic quality of  $p\mbox{-}Cu\mbox{InSe}_2$  on Mo films, of the kind used for thin film solar cells. We chose to use acetonitrile containing  $Co(bpy)_3(ClO_4)_2$  as the redox couple and tetraethylammonium perchlorate (TEAP) as supporting electrolyte (CAT). Using an outer sphere redox couple, such as this one, decreases the probability of specific adsorption, while use of a non-oxygenated organic solvent makes rapid surface oxidation less likely. In this way we could evaluate the effect of several surface treatments, the quality and homogeneity of films, and determine some effective optical and electronic properties of them. Such information was used for better control over, and improvement of preparation of the semiconductor films. For comparison, single crystals were studied, too.

In order to find out if the redox potentials of Co  $(bpy)_3^{3+/2+}$  and Co  $(bpy)_3^{2+/1+}$  fulfill the energetic requirements (hole [electron] transfer from n[p] type CuInSe<sub>2</sub>, respectively) we used single crystals to determine the dark and light I-V characteristics, as we can expect minimal dark currents for such electrodes. Figure 1 (a,b), shows the dark and photo I-V curves of n-CuInSe<sub>2</sub> and p-CuInSe<sub>2</sub> crystals. The same on-set potential at ~ -0.2 V vs. SCE was obtained for n- and p-type crystals. Therefore, the semiconductors as used here are not ideal ones. However, the results indicate that the redox potential (~ -0.9 V vs. SCE) of Co  $(bpy)_3^{2+/+}$  is located within the bandgap of p-CuInSe<sub>2</sub> and the redox potential (~ 0.3 V vs. SCE) of Co  $(bpy)_3^{3+/2+}$  falls within the bandgap of n-CuInSe<sub>2</sub> (SCE: Standard Calomel Electrode, -0.24V vs. the normal hydrogen electrode).

Thin films of p-CuInSe<sub>2</sub> as obtained, showed very small photocurrents in the absence of the redox agent, Co  $(bpy)_3^{2+}$  (Fig. 2a). In the presence of the latter, significant photocurrent was observed which started at ~ -0.2 V vs. SCE (Fig. 2b). Fig. 2c shows the improved photovoltaic activity of the film after etching in Br<sub>2</sub>/MeOH, with significant photocurrent starting around zero V vs. SCE. Several methods are available for the measurements of the flatband potential and here we



Figure 1. Chopped Current-Voltage Plots for: (a)  $p-CulnSe_2$  crystal (0.35 cm<sup>2</sup>); (b)  $n-CulnSe_2$  crystal (0.36 cm<sup>2</sup>), after etching in 2% Br<sub>2</sub>/MeOH for 30 sec and heating in air at 90°C for 1 hour. Co (bpy)<sub>3</sub> (ClO<sub>4</sub>)<sub>2</sub> concentration 0.2 M, 0.1 M TEAP in acetonitrile. Light intensity 1.5-2 × AM1.



Figure 2. Chopped Current-Voltage Plots for p-CulnSe<sub>2</sub> (0.28 cm<sup>2</sup>) in 0.1 M Co (bpy)<sub>3</sub> (CiO<sub>4</sub>)<sub>2</sub>, 0.1 M TEAP in acetonitrile. (a) without redox couple; (b) without etching; (c) after 30 sec etch in 0.5%  $Br_2$ /MeOH.

report on results from capacitance-voltage (Mott-Schottky) measurements. Fig. 3 shows Mott-Schottky plots for an as-grown film (that had been exposed to air for some time), and for a  $Br_2/MeOH$  etched film. The values obtained for the flatband potentials are -0.2 V and 0.0 V vs. SCE, respectively. These results agree fairly well with the potentials at which photocurrent starts (onset potentials) that can be obtained from Fig. 2.

The spatial homogeneity of a pattern of CuInSe<sub>2</sub> squares on Mo was tested in CAT. As shown in Fig. 4, six of the nine squares (area of each square =  $1 \text{ cm}^2$ ) on the checker board were evaluated for their individual photovoltaic activity, using illumination from a tungsten-halogen lamp. The lateral structure of the as-deposited films is also shown. Electrical contact was made directly to the Mo on alumina, between the squares. The photocurrent at -0.3 V vs. SCE was measured for each indi-The signficant difference in the vidual film. photocurrents between the left squares and the right squares showed the inhomogeneity of these films. The spatial homogeneity of an individual film was tested using laser scanning (11). Fig. 5 shows the results from such tests on a "Boeing" thin film (11 mm x 4 mm). The top gave better photoresponse than the bottom, while the best photoresponse was obtained in the middle. The results from these tests of spatial homogeneity of films or film patterns could be understood in terms of non-homogeneity of the deposition process (for the layer pattern) and from the effects of previous surface treatments (individual film).

## Photoelectrochemical Decomposition Studies

The use of organic solvent, e.g., acetonitrile, which has a wide working potential range



Figure 3. C<sup>-2</sup>-V Plots of p-CuInSe<sub>2</sub> Thin Film in 0.1 M Co (bpy)<sub>3</sub> (ClO<sub>4</sub>)<sub>2</sub>, 0.2 M TEAP in acetonitrile. (a) asgrown thin film; (b) etched in 0.2% Br<sub>2</sub>/MeOH for 10 minutes.

(from -2.0 V to +0.75 V vs. SCE for CuInSe<sub>2</sub> as shown in Fig. 2a), is useful for (photo) electrochemical studies of semiconductor electrodes. Therefore, many (photo) electrochemical decomposition products could be detected <u>in situ</u>, without solvent interference. It is known that CuInSe<sub>2</sub> can be oxidized after exposing it to air (13). Using etchants to produce reproducible surfaces for solar cells should be an important process to improve the cell performance.

While several etchants were identified previously (3), Mott-Schottky and I-V plots indicated that they did not always yield stable surfaces and



Figure 4. Top: Schematic pictures of p-CuInSe<sub>2</sub> on Mo checkerboard. Bottom: Results of PEC tests of six of the nine squares in CAT. Numbers of the IV curves refer to the numbers of the squares.



Figure 5. Laser Scan (intermittent illumination, spot size 25  $\mu$ m) of p-CuInSe<sub>2</sub> Film (outline shown on bottom right) in CAT. A 50 mW HeNe laser was used. Scan rates were 200  $\mu$ /sec left to right and top to bottom. Note that the measurements were done at -0.3 V vs. SCE. The film was etched in 0.5% (V/V) Br<sub>2</sub>/MeOH before measurement.

therefore we searched for alternative etching procedures. Etching with  $Br_2/MeOH$  was found to yield results more consistent than those obtained with the previously used acid/H<sub>2</sub>O/KCN/H<sub>2</sub>O etch. Analyses of etching solutions showed that 2% (V/V)  $Br_2/$ MeOH removes the constituent elements in a nearstoichiometric ratio. Surface analyses confirmed that a virtually clean surface, except for adsorbed oxygen and carbon, was obtained. After etching, it was annealed 3 hours at 150°C in air. On the basis of comparative surface analyses using the oxygen and indium Auger parameters, the In 3d line width, MNN Auger line shape, the relative X-ray photoelectron, and Auger intensities, we confirmed earlier indirect evidence (3b,5c,d), that an In-O bond formed upon air anneal, indicating the presence of indium oxide on the surface.

Results from investigations on the photoelectrochemical decomposition of  $CuInSe_2$  and its binary components,  $Cu_2Se$  and  $In_2Se_3$  are shown in Figs. 6,7. Figure 6a shows relevant results for  $Cu_2Se$  crystals in the dark. They are consistent with the anodic decomposition reaction:

$$Cu_2 Se^{-} 2Cu^{+} + Se^{-}$$
(1)

Figure 6b shows no electrochemical decomposition for  $In_2Se_3$  crystals in acetonitrile. Fig. 7 shows relevant results for n-CuInSe<sub>2</sub> crystals in the dark and under illumination. After anodic decomposition, three cathodic waves related to the reduction of  $Cu^{2+}$ ,  $Cu^+$  and Se<sup>0</sup> were detected in the dark. Atomic absorption analyses indicate the presence of only Cu in the acetonitrile solution after anodic decomposition. This is consistent with the anodic decomposition reaction:

$$n-CuInSe_2 \rightarrow 2Cu^{2+} + Se^0 + In_2 Se_3 + 4e^-$$
 (2)

Under illumination, two cathodic waves related to the reduction of  $Cu^+$  and  $Se^0$  were detected after anodic decomposition. Therefore, the photooxidation is:

2

$$2 \text{ n-CuInSe}_2 \xrightarrow{h\nu} 2\text{Cu}^+ + \text{Se}^\circ + \text{In}_2\text{Se}_3 + 2\text{e}^- \quad (3)$$

The above interpretation of the electrochemical results is supported by results from analyses of the contents of the solutions, after electrode decomposition. Surface analyses showed that the



Figure 6. Voltammetric Curves of  $Cu_2$  Se (------) and  $In_2$  Se<sub>3</sub> (------) in Acetonitrile of 0.1 M TEAP. Electrode area: 1 cm<sup>2</sup>. Scan rate: 50 mV/sec.



E (V vs. SCE)

**Figure 7. Voltammetric Curves of an n-CulnSe**<sub>2</sub> **Crystal in Acetonitrile of 0.1 M TEAP.** Electrode area: 0.1 cm<sup>2</sup>. Scan rate: 50 mV/sec Illumination intensity: 100 mW/cm<sup>2</sup> tungsten-halogen light a & e: Oxidation of lattice selenide to Se<sup>o</sup>. b: Reduction of Cu<sup>2+</sup> to Cu<sup>+</sup> c & f: Reduction of Cu<sup>+</sup> to Cu<sup>o</sup>. d & g: Reduction of Se<sup>o</sup> to Se<sup>2-</sup>.

top layer of the electrodes was partially depleted of Cu and In. From the above one can conclude that breaking of the Cu-Se bond is the primary step of anodic decomposition of CuInSe2. Anodic decomposition was also found in aqueous polyiodide solu-A golden film of Se<sup>O</sup> was observed after tion. photo-decomposition. AES profile analyses show Cu and In depletion on the surfaces. Solution analyses revealed the presence of some Cu, and possibly some In. Anodic decomposition of p-CuInSe<sub>2</sub> shows the same decomposition pathway as eq. (2) in the dark and under illumination. The rather facile removal of Cu from CuInSe<sub>2</sub> may be connected with the considerable range of stoichiometry, along the  $Cu_2Se-In_2Se_3$  tie line, for "CuInSe<sub>2</sub>", as determined from a series of solid state and structural chemical experiments. In fact, the chalcopyrite structure was found to be preserved down to x = 0.43(where x is the formula percent of Cu<sub>2</sub>Se in  $(Cu_2Se)_x(In_2Se_3)_{1-x})$  and related cubic structures could be found for stoichiometrics with x values as low as 0.25 (ref. 8, paper RNP 511; ref. 14).

# Photoelectrochemical Solar Cells

A 30 sec etch with 2% (V/V)  $Br_2/MeOH$  was found to be optimal for photovoltaic activity in aqueous polyiodide (Fig. 8 a,b). From experiments in polysulfide electrolytes we noted the beneficial effect of an air heating treatment on photoelectrode performance (3b, 5c,d). The treatment was optimized (Fig. 8 c,d) to yield an increase in the shortcircuit current, fill factor, and open-circuit voltage, after annealing 3 hours at 150°C. The formation of a more stoichiometric and more homogeneous indium oxide layer probably contributes to such effect. The combined effect of the surface etch and air anneal has a 30-fold increase of photovoltaic activity in aqueous polyiodide. While efficiencies well over 10% were measured for this system, decay in the short circuit photogurrents under ~ 1.25 x AMl illumination (~ 50 mA/cm<sup>2</sup>) after 10-30 minutes, was significant.

On the basis of results from these experiments and those from photoelectrochemical decomposition and those from photoerectronameter decomposition and solid state chemical studies, we investigated the effects of the addition of  $Cu^2$  and/or  $In^{3+}$  ions to the polyiodide solution.  $Cu^{2+}$  was added to the iodide solutions with which it reacted to give Cul (15). In such solutions a dramatic decrease in photocurrent decay was observed. Addition of Cu<sup>2+</sup> and In<sup>3+</sup> to iodide solutions produced an even stronger effect, and in some cases completely prevented photocurrent decay, without effecting the I-V characteristics. Most of these studies were conducted in nearly neutral aqueous solutions. At pH <9, no obvious pH effect on the I-V was found. However, at pH >9, poor cell performance was observed for the iodide/polyiodide solution probably due to slow charge transfer kinetics and iodide hydrolysis. Since illuminated iodide solutions are sensitive to air oxidation, especially at lower pH values (16), the pH of the solutions was always between 4 and 9.

To obtain, in a completely reproducible way, total electrode output stability, we electrode-posited a thin (0.3  $\mu m$  based on total geometric



Figure 8. Photocurrent-Photovoltage Curves for n-CuInSe<sub>2</sub> Single Crystal Electrodes in Aqueous 6M KI, 0.5 M I<sub>2</sub> Solution at pH  $\sim$  7, as Function of Surface Treatment a. Polished electrode. b. After subsequent 30 sec etch in 2% (V/V) Br<sub>2</sub>/MeOH. c. After subsequent 1 hour air anneal at 150° C d. As C, but for 3 hours. Solution redox potential (I<sub>3</sub>/I-) is + 0.30 V vs. SCE. Electrode area: 0.36 cm<sup>2</sup>; Light intensity: 1.5 × AM1.



Figure 9. Photocurrent-Photovoltage Curves for n-CulnSe<sub>2</sub> Electrodes in 6 M KI, 0.2 M Cu<sup>2+</sup> and 0.1 M In<sup>3+</sup>, pH ~7. The electrodes were optimized according to curve d in Fig. 8. Subsequently In was plated on the surface, and the plated electrdes were heated in air at 90° C for 3 1/2 hours. Electrode area:  $0.05 \text{ cm}^2$ . Illumination intensity was 120 mW/cm<sup>2</sup> from tungstenhalogen source.

area) layer of In on a previously optimized electrode and air-heated the plated electrode at  $90^{\circ}C$  for 3 1/2 hours. Such electrodes showed, consistently, no photocurrent decay in the modified polyiodide solutions, while retaining the favorable I-V characteristics of optimized electrodes (Fig. 9). Power conversion efficiencies of 10-11.7% were measured (under tungsten-halogen illumination of 120-145 mW/cm<sup>2</sup>, cf. legend to Fig. 9) for these systems. At 50 mA/cm<sup>2</sup> short-circuit current, some 20 kC/cm<sup>2</sup> photocharge passed with no change in the electrode surface. Similarly, at 40 mA/cm<sup>2</sup>, max-

imum power current, more than 15 kC/cm<sup>2</sup> photocharge passed while all output characteristics were retained. These results are thus comparable with those for CuInS<sub>2</sub> and CuInSe<sub>2</sub> in polysulfide electrolyte, but at significantly higher conversion efficiencies.

#### ACKNOWLEDGMENTS

We thank L.L. Kazmerski, S.K. Deb, A. Hermann, W. Wallace and K. Zweibel (SERI) for their help and encouragement. We are extremely grateful to R. Axton, R.A. Mickelson, and F.A. Thiel for samples of thin films and p-single crystals, respectively. The work described here was supported by the Solar Energy Research Institute, which is operated under DOE Contract No. DE-AC02-83CH10093.

#### REFERENCES

- W.S. Chen and R.A. Mickelsen, Proc. SPIE, <u>248</u>, 62 (1981).
- S. Wagner et al., Appl. Phys. Lett., <u>26</u>, 229 (1975).
- 3a. Y. Mirovsky and D. Cahen, <u>ibidem</u>, <u>40</u>, 727 (1982).
- b. Y. Mirovsky, Ph.D. thesis, Feinberg Grad. School, the Weizmann Inst. of Science, Rehovot, Israel (1983).
- J.L. Shay and J.H. Wernick, "Ternary Chalcopyrite Semiconductors; Growth, Electronic Properties and Applications"; Pergmon Press, New York (1975).
- 5a. M. Robbins, K.J. Bachmann, V.G. Lambrecht, F.A. Thiel, J. Thomson Jr., R.G. Vadimsky, S. Menezes, A. Heller, and B. Miller, J. Electrochem. Soc., <u>125</u>, 831 (1978).
- Y. Mirovsky, D. Cahen, G. Hodes, R. Tenne and W. Giriat, Solar Energy Mat., <u>4</u>, 169 (1981).
- c. D. Cahen, Y. Mirovsky and R. Tenne, in "Solid State Chemistry, 1982", Studies in Inorganic Chem., Vol. 3, S.R. Metselaar, H.J. Heijligers and J. Schoonman eds., Elsevier, Amsterdam (1983), p. 173 ff.
- d. Y. Mirovsky, G. Djemal and D. Cahen, Il Nuovo Cim. D, <u>2</u>, 2039 (1983).
- e. E.C. Deng and P.D. Li, Acta Energ. Solar. Sinica 2, 182 (1981); E.C. Deng, <u>ibidem</u>, <u>3</u>, 112 (1982).
- 6a. F.F. Fan, M.S. White, B. Wheeler and A.J. Bard, J. Electrochem. Soc., <u>127</u>, 518 (1980).

- b. Y. W. Chen, Ph.D. Thesis, University of Texas, Austin (1982).
- c. F.R. Fan, G. Nagasubramanian, R.G. Keil, B.L. Wheeler, G.A. Hope, Y.W.D. Chen, and A.J. Bard, "Photoelectrochemical Systems for Energy Conversion and Storage", DOE/SERI Review of Electrochemical Photovoltaic Cells, Denver, Colorado, June, 1982. SERI/cp-613-985; p. 25-33.
- J. Gobrecht, H. Gerischer, and H. Tributsch, J. Electrochem. Soc., <u>125</u>, 2085 (1978).
- A.J. Bard, J. Photochem. <u>10</u>, 59 (1979); Science <u>207</u>, 139 (1980); J. Phys. Chem., <u>86</u>, 172 (1982).
- 8. Our results and some similar ones of S. Menezes <u>et al.</u> were reported at the 164th Electrochem. Soc. Meeting, October 1983 in papers RNP 511-513 and RNP 508 resp. (J. Electrochem. Soc. <u>130</u> (11) 442C, 443C (1983), and recently by the latter authors in Nature, 305, 615 (1983).
- C. Rincon, J. Gonzalez, and G. Sanchez Perez, Phys. Stat. Sol (b) <u>108</u>, K19 (1981).
- 10. K.J. Bachmann, DOE/SERI Review of Polycrystalline Compound Solar Cells, Golden, Colorado, May, 1983; SERI/cp-311-2011; p. 1.
- 11. T. E. Furtak, D.C. Canfield, and B. A. Parkinson, J. Appl. Phys, <u>51</u>, 6018 (1980).
- 12. G. Cooper, J.A. Turner, and A.J. Nozik, J. Electrochem. Soc., <u>129</u>, 1973 (1982).
- 13a. L.L. Kazmerski, O. Jamjoum, P.J. Ireland, S.K. Deb, R.A. Mickelsen, and W.S. Chen, J. Vac. Sci. Technol. <u>19</u>, 467 (1981).
- b. L.L. Kazmerski, O. Jamjoum, J.F. Wager, P.J. Ireland and K.J. Bachmann, <u>ibidem</u>, <u>Al</u>, 668 (1983).
- 14. J.C.W. Folmer in "Abstracts of Presentation, 7th Photoelectrochemical Cell Contractors Review Meeting", DOE/SERI, Dec. 1983, Golden, CO., pp. 93-100; J.C.W. Folmer, J.A. Turner, R. Noufi and D. Cahen, submitted.
- J. Readman and D.A. House, Polyhedron, <u>1</u>, 611 (1982).
- 16a. E. Abel, Monatsh, 83, 818 (1952).
- b. J. Sigalla and C. Herbo, J. Chim. Phys. <u>54</u>, 733 (1957).
- c. S. Witehowa and W. Kaminski, Zess. Nauk. Politech. Lods., Chem. <u>27</u>, 51 (1973).